

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10594973	MUKAIDA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	BAOQUOC N TO	2162

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	1,101 (with keywords)	9/26/2008	bto
707	1,101 (with keywords)	04/04/2009	bto
707	1, 10 (with keywords)	09/25/2009	bto
707	1, 10 (with keywords)	03/11/2010	bto

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search (US-PGPUB, USPAT, USOCR, FPLRS, EPO, JPO, DERWENT, IBM_TDB)	09/26/2008	bto
Inventor search (PALM-related cases)	09/26/2008	bto
Updated search - text search (US-PGPUB, USPAT, USOCR, FPLRS, EPO, JPO, DERWENT, IBM_TDB)	04/04/2009	bto
Updated search - text search (US-PGPUB, USPAT, USOCR, FPLRS, EPO, JPO, DERWENT, IBM_TDB)	09/25/2009	bto
Updated search - text search (US-PGPUB, USPAT, USOCR, FPLRS, EPO, JPO, DERWENT, IBM_TDB)	03/11/2010	bto

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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